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Dual NPN Bias Resistor Transistors R1 = 22 k\Omega, R2 = 22 k\Omega

NPN Transistors with Monolithic Bias Resistor Network

This series of digital transistors is designed to replace a single device and its external resistor bias network. The Bias Resistor Transistor (BRT) contains a single transistor with a monolithic bias network consisting of two resistors; a series base resistor and a base-emitter resistor. The BRT eliminates these individual components by integrating them into a single device. The use of a BRT can reduce both system cost and board space.

Features

- Simplifies Circuit Design
- Reduces Board Space
- Reduces Component Count
- S and NSV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable*
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS

(T_A = 25°C, common for Q_1 and $Q_2,$ unless otherwise noted)

Rating	Symbol	Max	Unit
Collector-Base Voltage	V _{CBO}	50	Vdc
Collector-Emitter Voltage	V _{CEO}	50	Vdc
Collector Current – Continuous	Ι _C	100	mAdc
Input Forward Voltage	V _{IN(fwd)}	40	Vdc
Input Reverse Voltage	V _{IN(rev)}	10	Vdc

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

ORDERING INFORMATION

Device	Package	Shipping [†]
MUN5212DW1T1G, NSVMUN5212DW1T1G*	SOT-363	3,000/Tape & Reel
NSBC124EDXV6T1G	SOT-563	4,000/Tape & Reel
NSBC124EDXV6T5G	SOT-563	8,000/Tape & Reel
NSBC124EDP6T5G	SOT-963	8,000/Tape & Reel

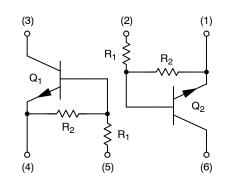
⁺For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



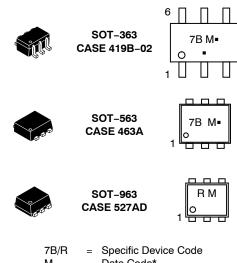
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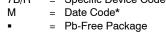
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PIN CONNECTIONS



MARKING DIAGRAMS





(Note: Microdot may be in either location)

*Date Code orientation may vary depending upon manufacturing location.

THERMAL CHARACTERISTICS

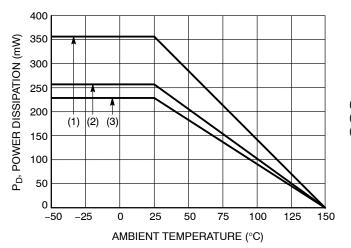
	Characteristic	Symbol	Max	Unit
MUN5212DW1 (SOT-363) ONE JU	INCTION HEATED			
Total Device Dissipation $T_A = 25^{\circ}C$ (Note 49)(Note 50)Derate above $25^{\circ}C$ (Note 50)	te 49)	PD	187 256 1.5 2.0	mW mW/°C
	te 49) te 50)	R _{θJA}	670 490	°C/W
MUN5212DW1 (SOT-363) BOTH	JUNCTION HEATED (Note 51)			
$\begin{array}{l} \hline Total Device Dissipation \\ T_A = 25^\circ C & (Note 49) \\ & (Note 50) \\ Derate above 25^\circ C & (Note 50) \\ \hline \end{array}$	te 49)	PD	250 385 2.0 3.0	mW mW/°C
Thermal Resistance, Junction to Ambient (No (Note 50)	te 49)	R _{θJA}	493 325	°C/W
Thermal Resistance, Junction to Lead (Note 49) (Note 50)		R _{θJL}	188 208	°C/W
Junction and Storage Temperature	Range	T _J , T _{stg}	–55 to +150	°C
NSBC124EDXV6 (SOT-563) ONE	JUNCTION HEATED			
Total Device Dissipation $T_A = 25^{\circ}C$ (Note 49) Derate above $25^{\circ}C$ (No	te 49)	PD	357 2.9	mW mW/°C
Thermal Resistance, Junction to Ambient (No	te 49)	R _{θJA}	350	°C/W
NSBC124EDXV6 (SOT-563) BOT	H JUNCTION HEATED (Note 51)		· · ·	
Total Device Dissipation $T_A = 25^{\circ}C$ (Note 49)Derate above $25^{\circ}C$ (No	te 49)	PD	500 4.0	mW mW/°C
Thermal Resistance, Junction to Ambient (No	te 49)	R _{θJA}	250	°C/W
Junction and Storage Temperature	Range	T _J , T _{stg}	-55 to +150	°C
NSBC124EDP6 (SOT-963) ONE J	UNCTION HEATED			
Total Device Dissipation $T_A = 25^{\circ}C$ (Note 52) (Note 53) Derate above 25^{C} (Note 53)	te 52)	PD	231 269 1.9 2.2	MW mW/°C
Thermal Resistance,	te 52)	R _{θJA}	540 464	°C/W
NSBC124EDP6 (SOT-963) BOTH	JUNCTION HEATED (Note 51)			
$\begin{array}{l} \mbox{Total Device Dissipation} \\ T_A = 25^\circ C & (Note 52) \\ (Note 53) \\ \mbox{Derate above } 25^\circ C & (Note 53) \\ \end{array}$	te 52)	PD	339 408 2.7 3.3	MW mW/°C
Thermal Resistance, Junction to Ambient (No (Note 53)	te 52)	R _{θJA}	369 306	°C/W
Junction and Storage Temperature		T _J , T _{stg}	-55 to +150	°C

49.1 R-4 @ Minimum Fau.
50. FR-4 @ 1.0 × 1.0 Inch Pad.
51. Both junction heated values assume total power is sum of two equally powered channels.
52. FR-4 @ 100 mm², 1 oz. copper traces, still air.
53. FR-4 @ 500 mm², 1 oz. copper traces, still air.

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					
Collector-Base Cutoff Current $(V_{CB} = 50 \text{ V}, I_E = 0)$	I _{CBO}	_	-	100	nAdc
Collector-Emitter Cutoff Current $(V_{CE} = 50 \text{ V}, I_B = 0)$	I _{CEO}	-	-	500	nAdc
Emitter-Base Cutoff Current ($V_{EB} = 6.0 \text{ V}, I_C = 0$)	I _{EBO}	-	-	0.2	mAdc
Collector-Base Breakdown Voltage $(I_C = 10 \ \mu A, I_E = 0)$	V _{(BR)CBO}	50	-	-	Vdc
Collector-Emitter Breakdown Voltage (Note 54) $(I_{C} = 2.0 \text{ mA}, I_{B} = 0)$	V _{(BR)CEO}	50	-	_	Vdc
ON CHARACTERISTICS					
DC Current Gain (Note 54) $(I_C = 5.0 \text{ mA}, V_{CE} = 10 \text{ V})$	h _{FE}	60	100	-	
Collector-Emitter Saturation Voltage (Note 54) $(I_{C} = 10 \text{ mA}, I_{B} = 0.3 \text{ mA})$	V _{CE(sat)}	-	-	0.25	V
Input Voltage (Off) (V _{CE} = 5.0 V, I _C = 100 μA)	V _{i(off)}	-	1.2	-	Vdc
Input Voltage (On) (V _{CE} = 0.2 V, I _C = 5.0 mA)	V _{i(on)}	-	1.9	-	Vdc
Output Voltage (On) (V_{CC} = 5.0 V, V_B = 2.5 V, R_L = 1.0 k Ω)	V _{OL}	-	-	0.2	Vdc
Output Voltage (Off) (V_{CC} = 5.0 V, V_B = 0.5 V, R_L = 1.0 k Ω)	V _{OH}	4.9	-	_	Vdc
Input Resistor	R1	15.4	22	28.6	kΩ
Resistor Ratio	R ₁ /R ₂	0.8	1.0	1.2	

ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$, common for Q_1 and Q_2 , unless otherwise noted)

54. Pulsed Condition: Pulse Width = 300 ms, Duty Cycle \leq 2%.



(1) SOT–363; 1.0×1.0 Inch Pad

(2) SOT-563; Minimum Pad

(3) SOT-963; 100 mm², 1 oz. Copper Trace

Figure 130. Derating Curve

V_{CE(sat)}, COLLECTOR-EMITTER VOLTAGE (V) 1 1000 V_{CE} = 10 $I_{\rm C}/I_{\rm B} = 10$ 25°C 25°C h_{FE}, DC CURRENT GAIN = 75° T₄ T_A = −25°C 0.1 -25°C 75°C 100 0.01 10 0.001 10 100 0 1 20 40 50 I_C, COLLECTOR CURRENT (mA) I_C, COLLECTOR CURRENT (mA) Figure 132. DC Current Gain Figure 131. V_{CE(sat)} vs. I_C 3.2 100 25°C 75°Ċ Cob, OUTPUT CAPACITANCE (pF) Ic, COLLECTOR CURRENT (mA) 2.8 f = 10 kHz $T_A = -25^{\circ}C$ $I_E = 0 A$ 10 2.4 T_A = 25°C 2.0 1 1.6 0.1 1.2 0.8 0.01 $V_0 = 5 V$ 0.4 0.001 L 0 0 20 30 40 50 6 8 10 10 2 4 V_R, REVERSE VOLTAGE (V) Vin, INPUT VOLTAGE (V)

TYPICAL CHARACTERISTICS MUN5212DW1, NSBC124EDXV6

Figure 133. Output Capacitance

Figure 134. Output Current vs. Input Voltage

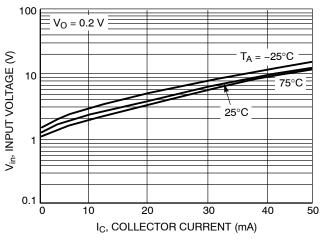
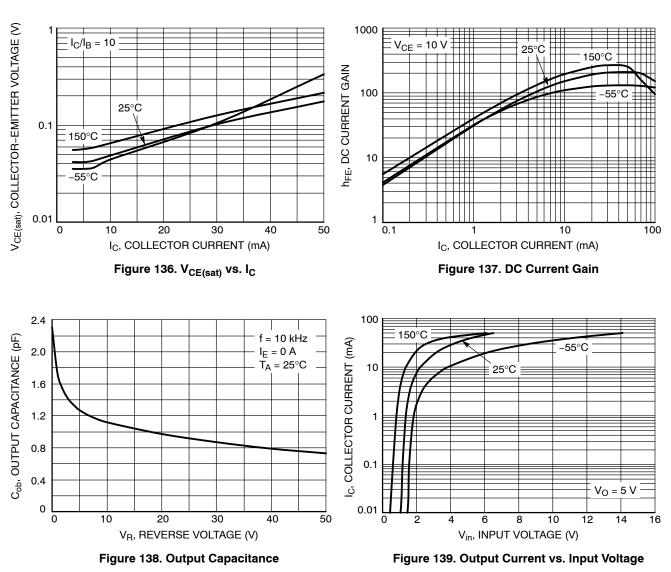
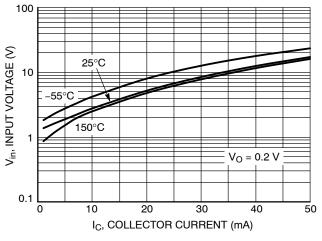


Figure 135. Input Voltage vs. Output Current

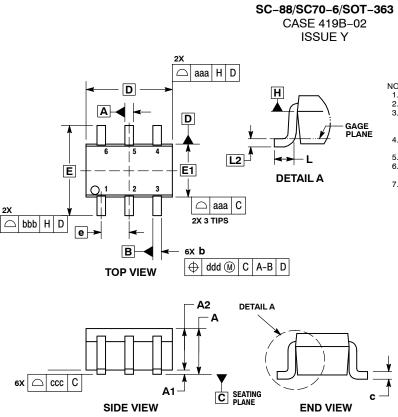


TYPICAL CHARACTERISTICS NSBC124EDP6





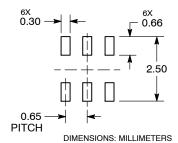
PACKAGE DIMENSIONS



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS.
- З.
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRU-SIONS, OR GATE BURRS SHALL NOT EXCEED 0.20 PER END. DIMENSIONS D AND E1 AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY AND DATUM H. DATUMS A AND B ARE DETERMINED AT DATUM H. DIMENSIONS b AND c APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.08 AND 0.15 FROM THE TIP. DIMENSION b DORS NOT INCLUDE DAMBAB PROTBUISION
- 5. 6.
- 7. DIMENSION & DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN EXCESS OF DIMENSION 6 AT MAXIMUM MATERIAL CONDI-TION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α			1.10			0.043
A1	0.00		0.10	0.000		0.004
A2	0.70	0.90	1.00	0.027	0.035	0.039
b	0.15	0.20	0.25	0.006	0.008	0.010
С	0.08	0.15	0.22	0.003	0.006	0.009
D	1.80	2.00	2.20	0.070	0.078	0.086
Е	2.00	2.10	2.20	0.078	0.082	0.086
E1	1.15	1.25	1.35	0.045	0.049	0.053
e		0.65 BS	C	0.026 BSC		
L	0.26	0.36	0.46	0.010	0.014	0.018
L2	0.15 BSC			0.006 BSC		
aaa	0.15		0.006			
bbb	0.30			0.012		
CCC	0.10		0.004			
ddd	0.10				0.004	

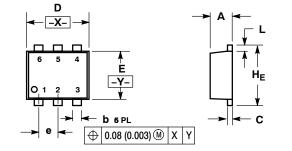
RECOMMENDED SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

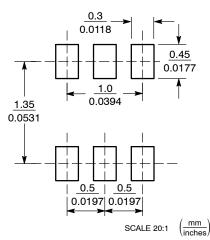
SOT-563, 6 LEAD CASE 463A ISSUE G



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETERS
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.50	0.55	0.60	0.020	0.021	0.023
b	0.17	0.22	0.27	0.007	0.009	0.011
С	0.08	0.12	0.18	0.003	0.005	0.007
D	1.50	1.60	1.70	0.059	0.062	0.066
ш	1.10	1.20	1.30	0.043	0.047	0.051
е	0.5 BSC		0	0.02 BSC)	
Г	0.10	0.20	0.30	0.004	0.008	0.012
HE	1.50	1.60	1.70	0.059	0.062	0.066

SOLDERING FOOTPRINT*

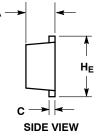


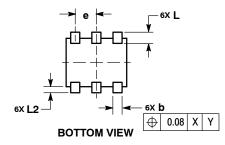
*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS









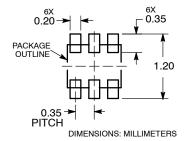
NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.34	0.37	0.40		
b	0.10	0.15	0.20		
С	0.07	0.07 0.12 0.17			
D	0.95	1.00	1.05		
Е	0.75	0.80	0.85		
е	0.35 BSC				
ΗE	0.95	1.00	1.05		
L	0.19 REF				
L2	0.05	0.10	0.15		

RECOMMENDED MOUNTING FOOTPRINT*



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